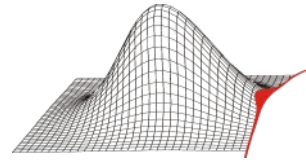


Introduction into Probabilistic Methods and their Application in Engineering Sciences with Focus on Monte-Carlo and Response Surface Methods

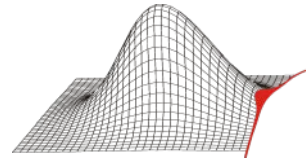
David Pusch
André Beschorner
Robin Schmidt

7. Dresdner Probabilistik-Workshop
Dresden 08. – 09.10.2014





- Introduction
- Part 1: Basics of Statistics
- Part 2: Regression
- Part 3: Probabilistic System Analysis
using Monte-Carlo Methods

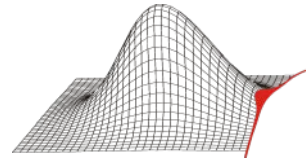


Two turbine blades from the same engine...

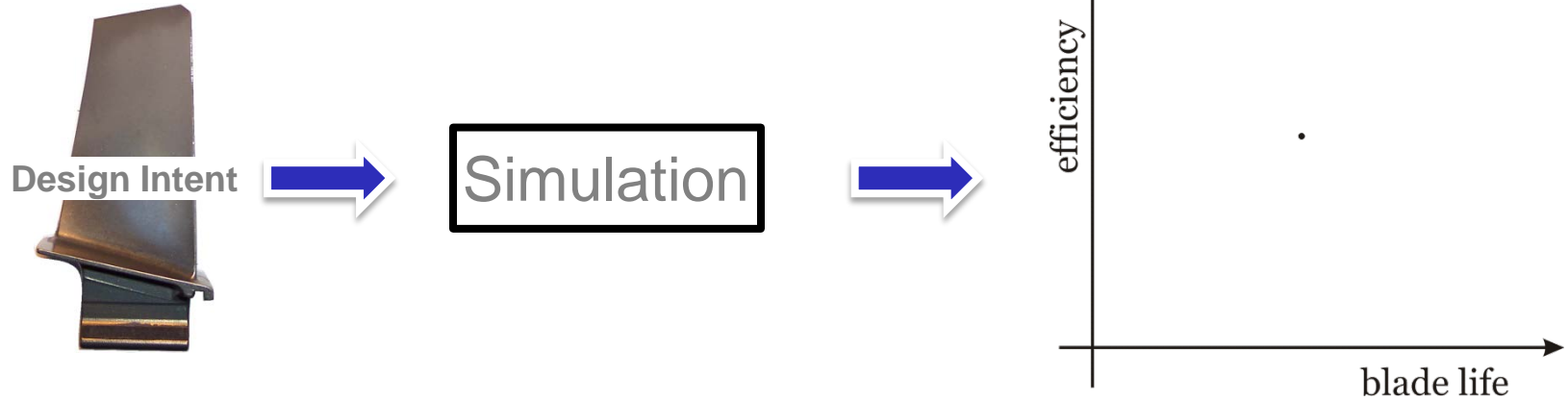


Massachusetts Institute of Technology, Prof. David L. Darmofal

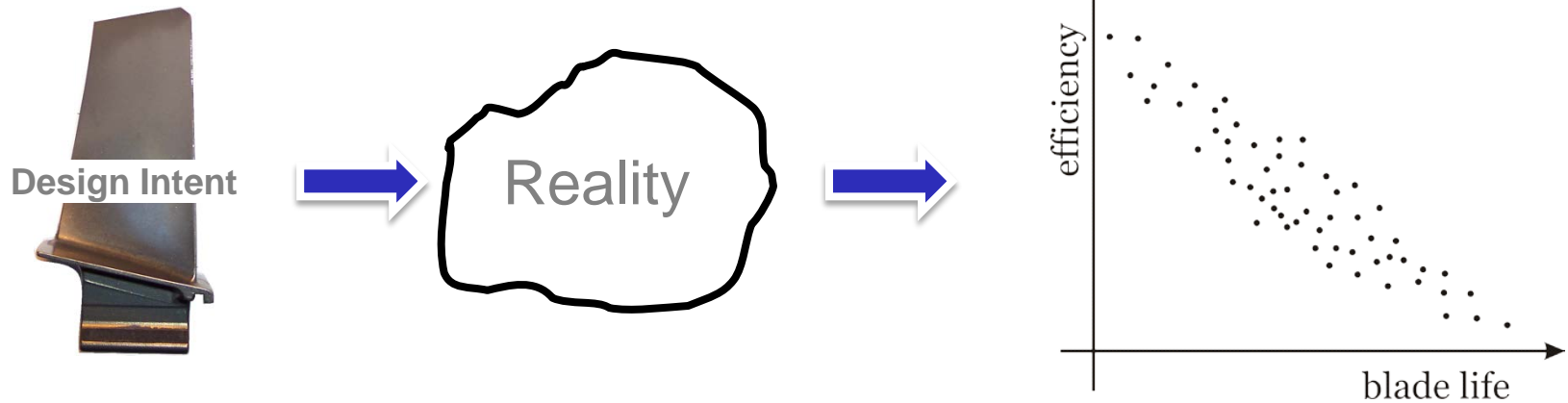
... but with clearly different life

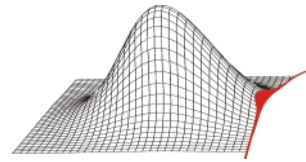


- Classic simulation-based approach used in design



- Real behavior of physical system





Stochastic Theory



Combinatorics

How many possibilities are there to arrange elements, or to pick elements from a population?



Statistics

collection, analysis, interpretation, presentation and organization of data

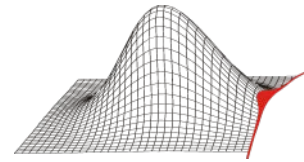


Probabilistic

investigation and modeling of random events

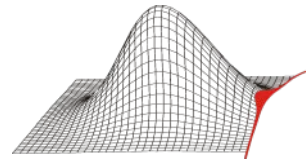


prediction of random events

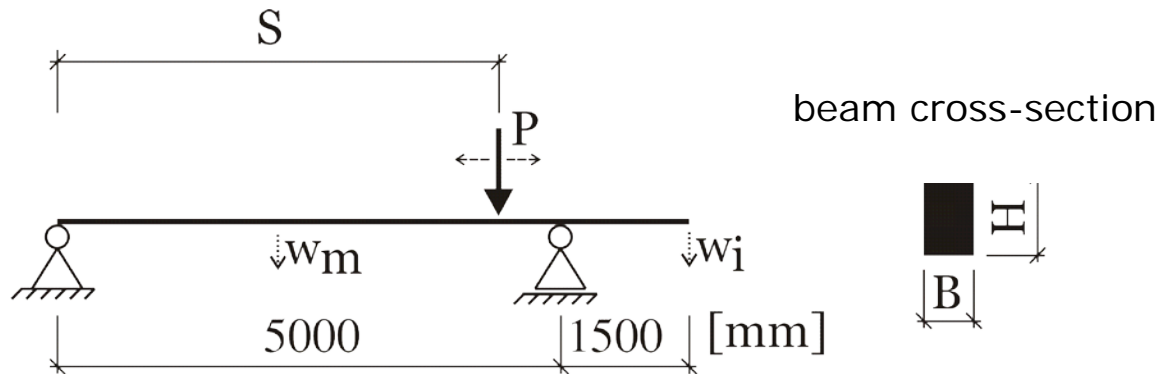


Probabilistic System Analysis

Deterministic
Model



cantilever beam with two supports



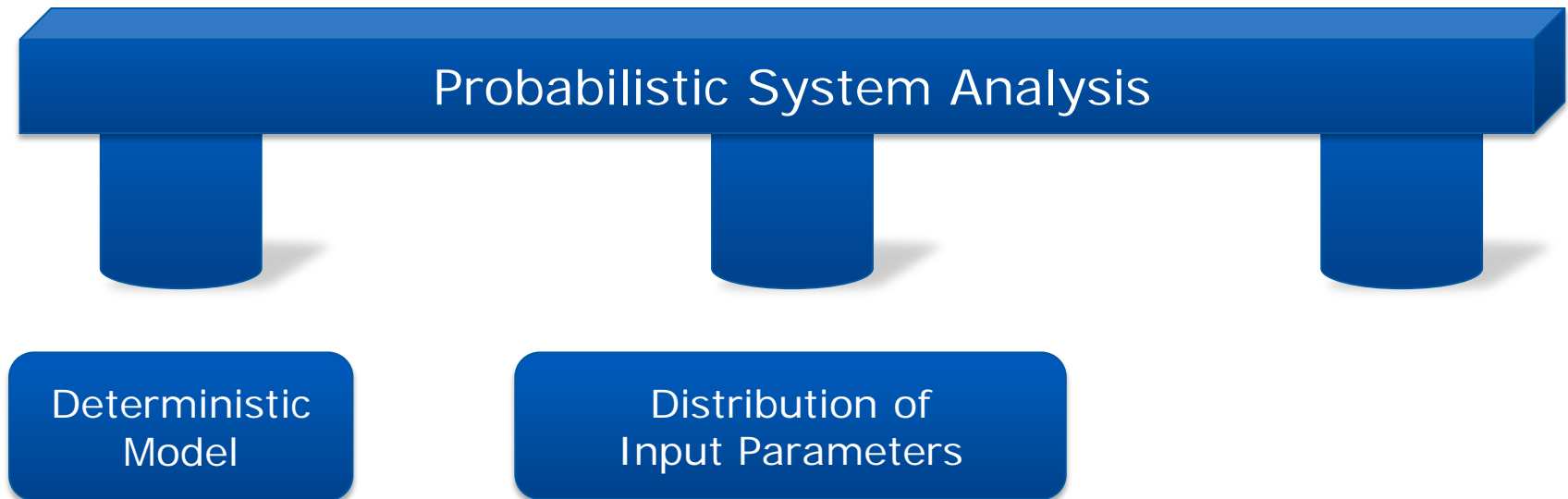
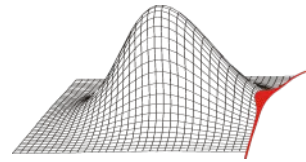
input parameters:

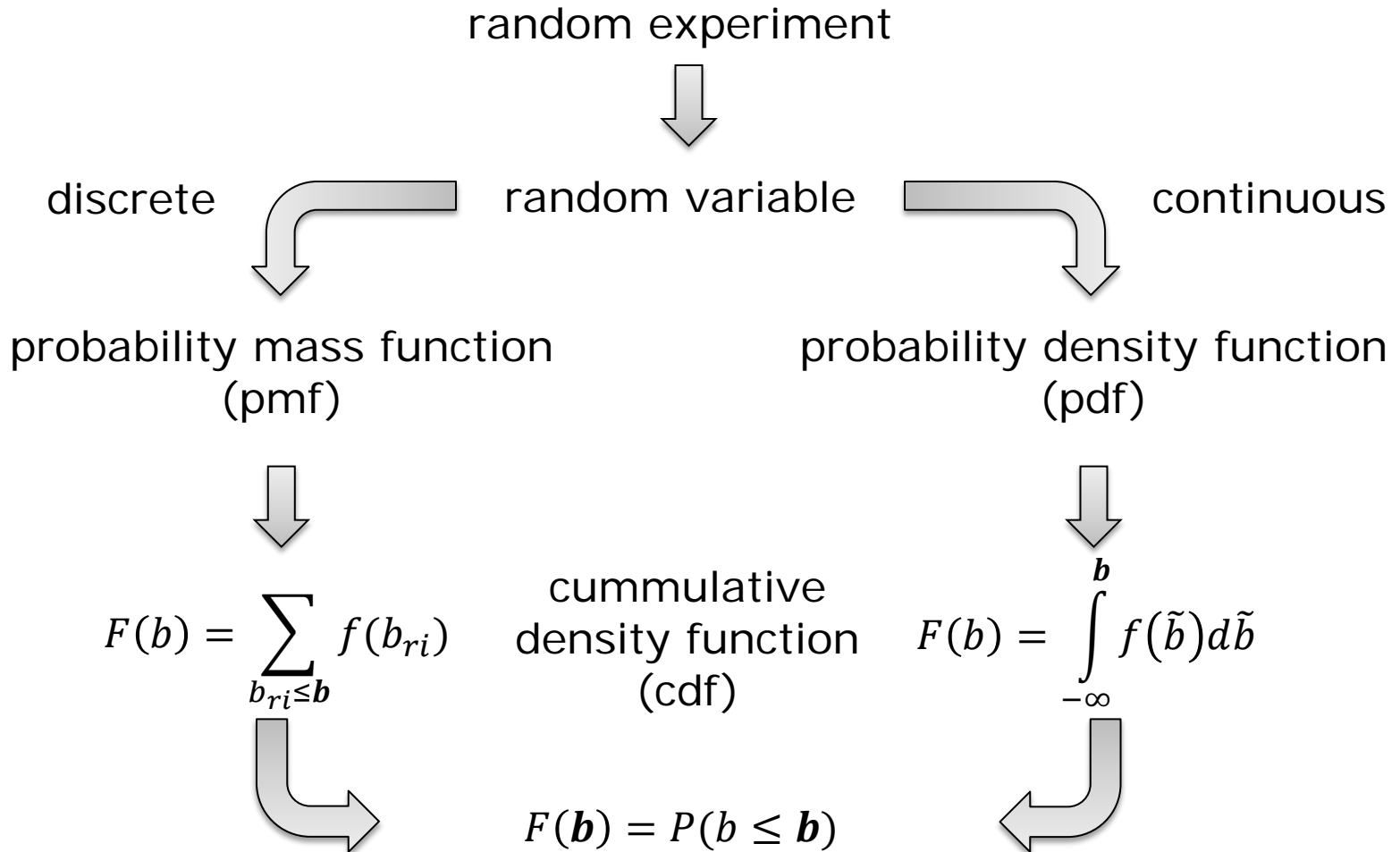
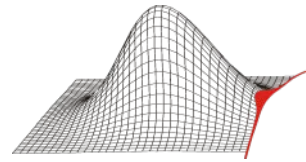
- H ... beam height
- B ... beam width
- P ... point load
- S ... position of point load
- Young's modulus

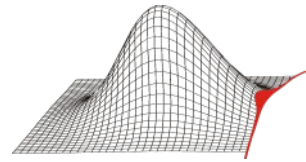


result values:

- deflections w_m, w_i

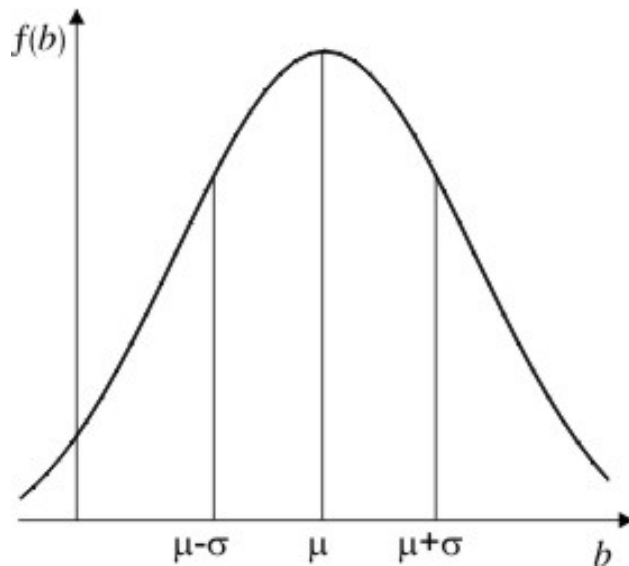




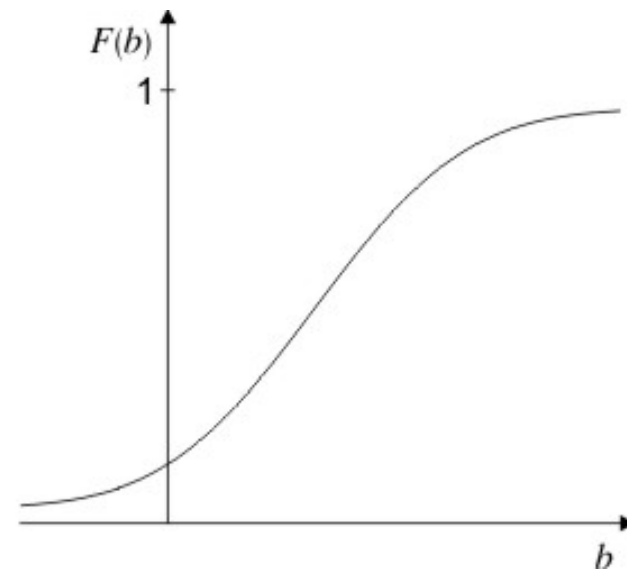


[1]

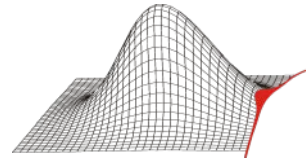
also called "Normal Distribution"



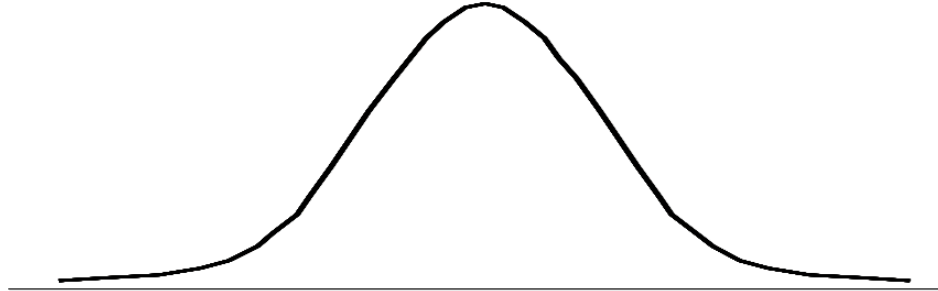
$$f(b) = \frac{1}{\sigma\sqrt{2\pi}} \exp\left[-\frac{(b - \mu)^2}{2\sigma^2}\right]$$



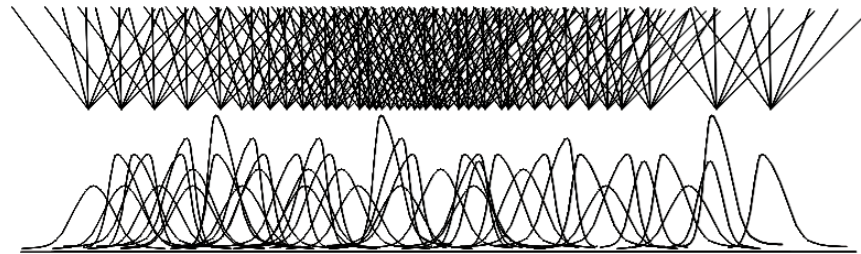
$$F(b) = \frac{1}{\sigma\sqrt{2\pi}} \int_{-\infty}^b \exp\left[-\frac{(\tilde{b} - \mu)^2}{2\sigma^2}\right] d\tilde{b}$$



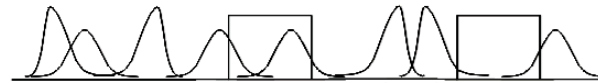
Weight



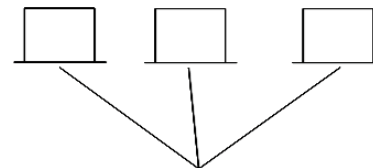
Coating

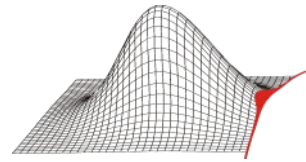


Die, Configuration,
Batch

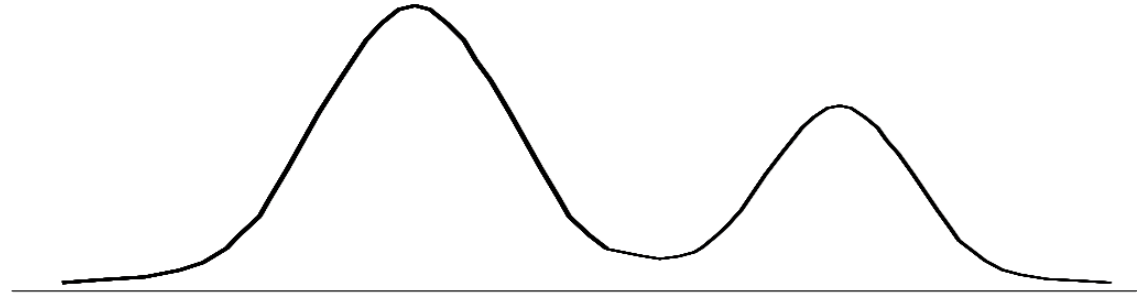


Supplier

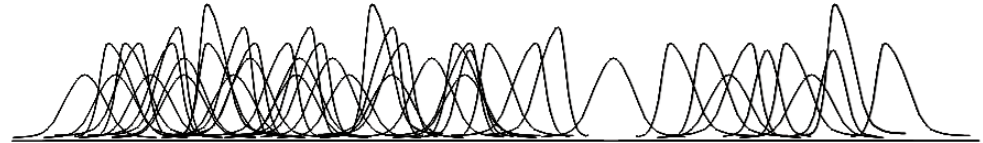
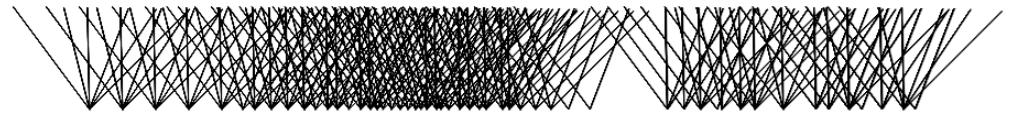




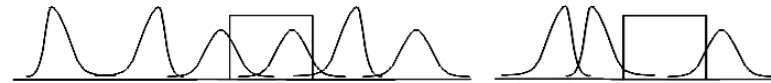
Weight



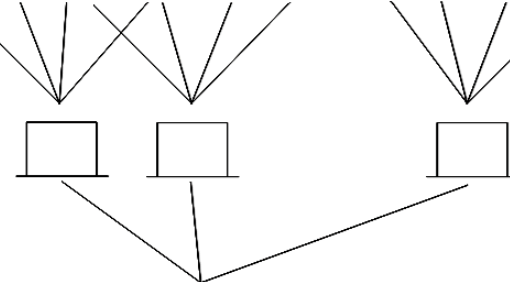
Coating

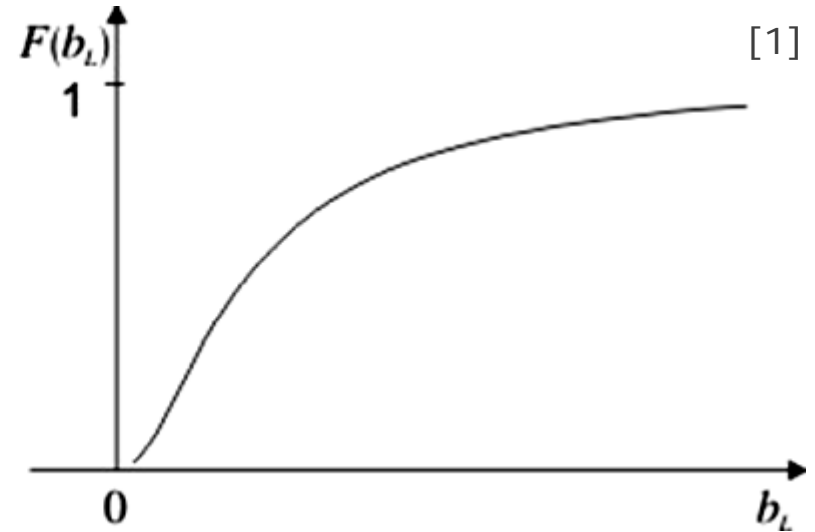
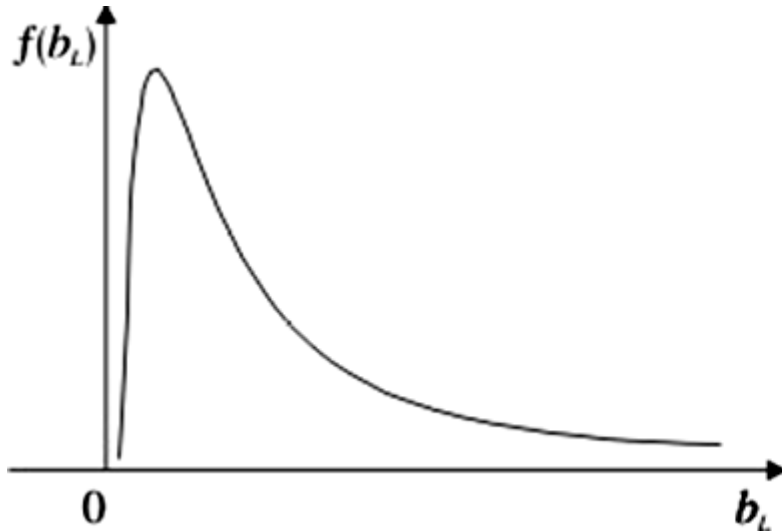
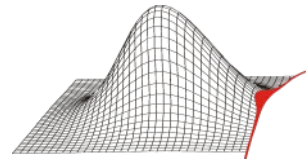


Die, Configuration,
Batch



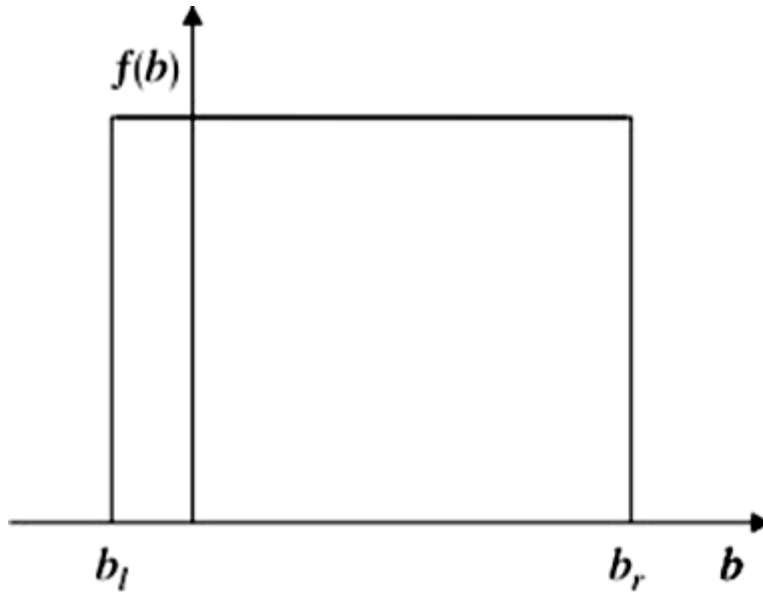
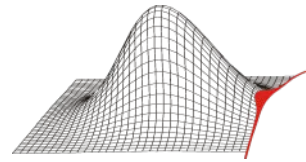
Supplier



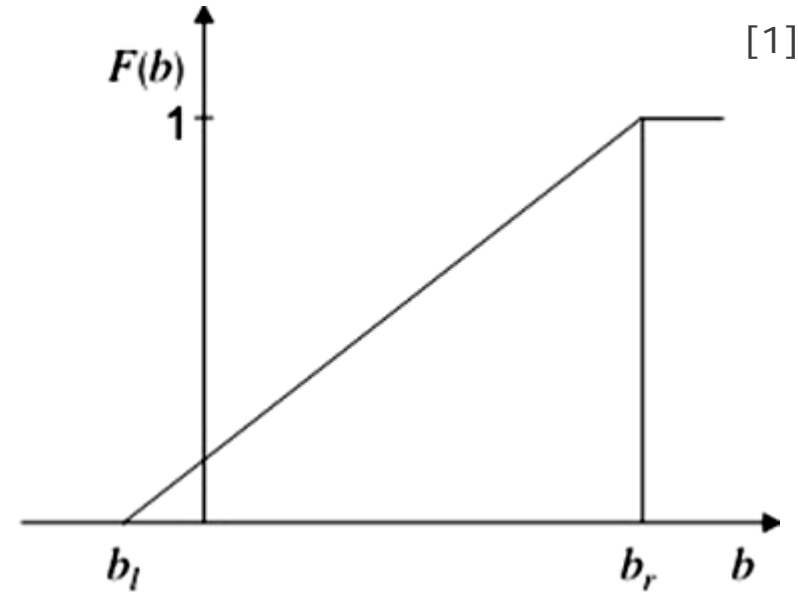


$$f(b_L) = \begin{cases} \frac{1}{\zeta \sqrt{2\pi} b_L} \exp \left\{ -\frac{(\ln b_L - \lambda)^2}{2 \zeta^2} \right\} & \text{für } b_L > 0 \\ 0 & \text{sonst} \end{cases}$$

$$F(b_L) = \begin{cases} \frac{1}{\zeta \sqrt{2\pi}} \int_0^{b_L} \frac{1}{\tilde{b}_L} \exp \left\{ -\frac{(\ln \tilde{b}_L - \lambda)^2}{2 \zeta^2} \right\} d\tilde{b}_L & \text{für } \tilde{b}_L > 0 \\ 0 & \text{sonst} \end{cases} \quad [1]$$

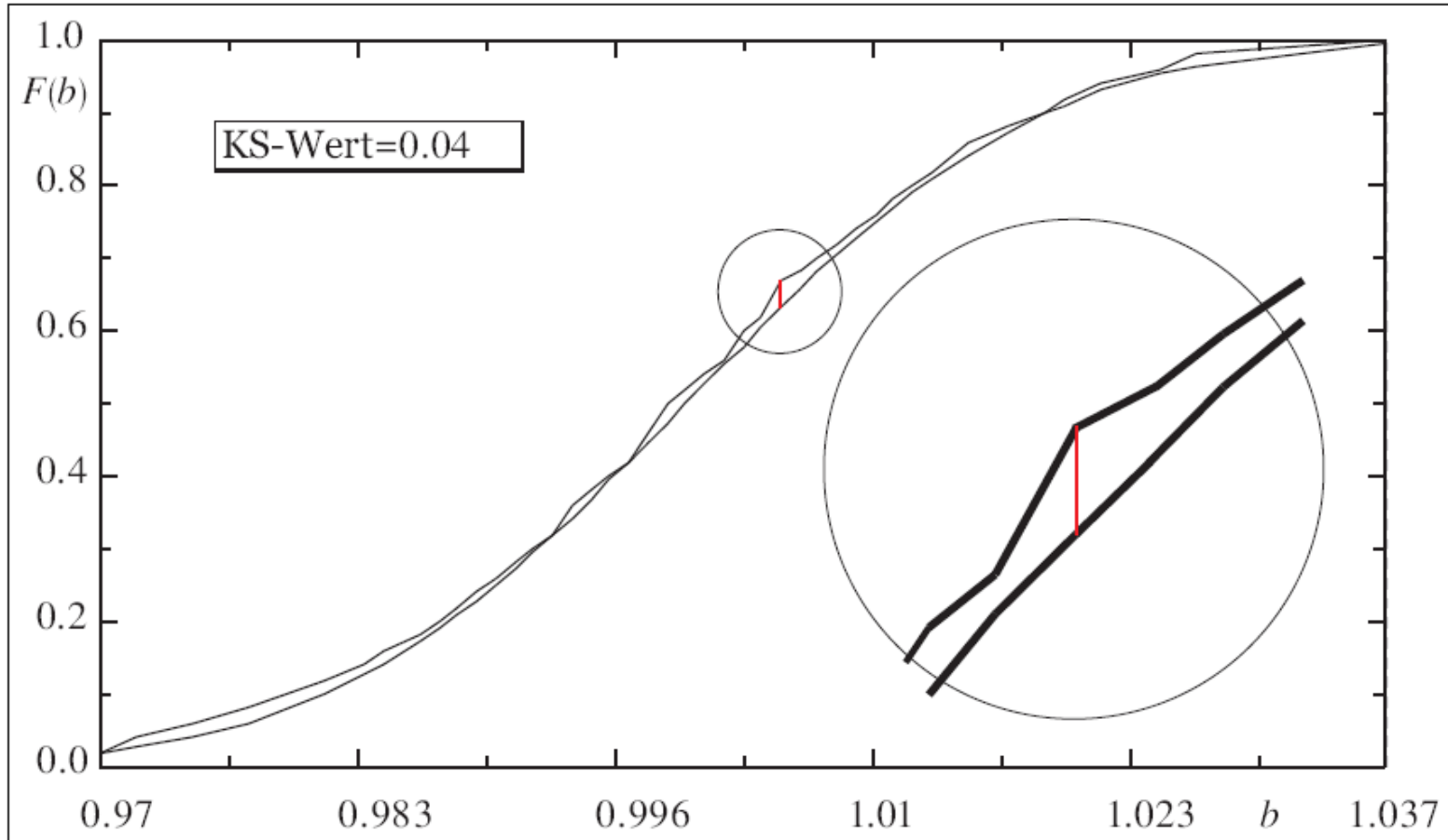
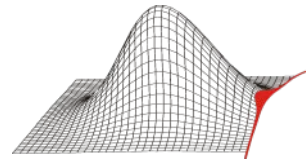


$$f(b) = \begin{cases} \frac{1}{b_r - b_l} & b_l \leq b \leq b_r \\ 0 & \text{sonst} \end{cases}$$

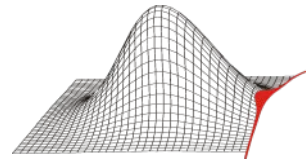


[1]

$$F(b) = \begin{cases} 0 & b < b_l \\ \frac{b - b_l}{b_r - b_l} & b_l \leq b \leq b_r \\ 1 & b > b_r \end{cases}$$



$$KS = \max_{-\infty < b_k < \infty} |F_d(b_k) - F_s(b_k)|$$



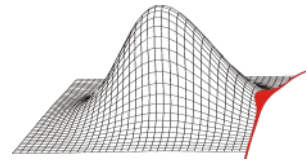
- is a modification of the Kolmogorow-Smirnow-Test
- deviations between test- and target distribution are stronger weighted at the edges than in the midsection of the distribution function [2]

$$A^2 = -n_{sim} - \frac{1}{n_{sim}} \sum_k^{n_{sim}} (2k - 1) (\ln F_S(b_k) + \ln [1 - F_S(b_{n_{sim}+1-k})])$$

- F_S is the cumulative distribution function of the test data
- tables of critical values of A for different distributions are available in [3] for example

[2] Anderson, T. W., Darling, D.A., 1952, Asymptotic Theory of Certain "Goodness of Fit" Criteria Based on Stochastic Processes, Annals of Mathematical Statistics 23, Pages 193-212

[3] Stephens, M.A., 1974, EDF Statistics for Goodness of Fit and some Comparisons, Journal of the American Statistical Association, Vol. 69, Pages 730-737



- **arithmetic mean:**
$$\bar{b}_{ri} = \frac{1}{n_{sim}} \sum_{k=1}^{n_{sim}} b_{ri,k}$$

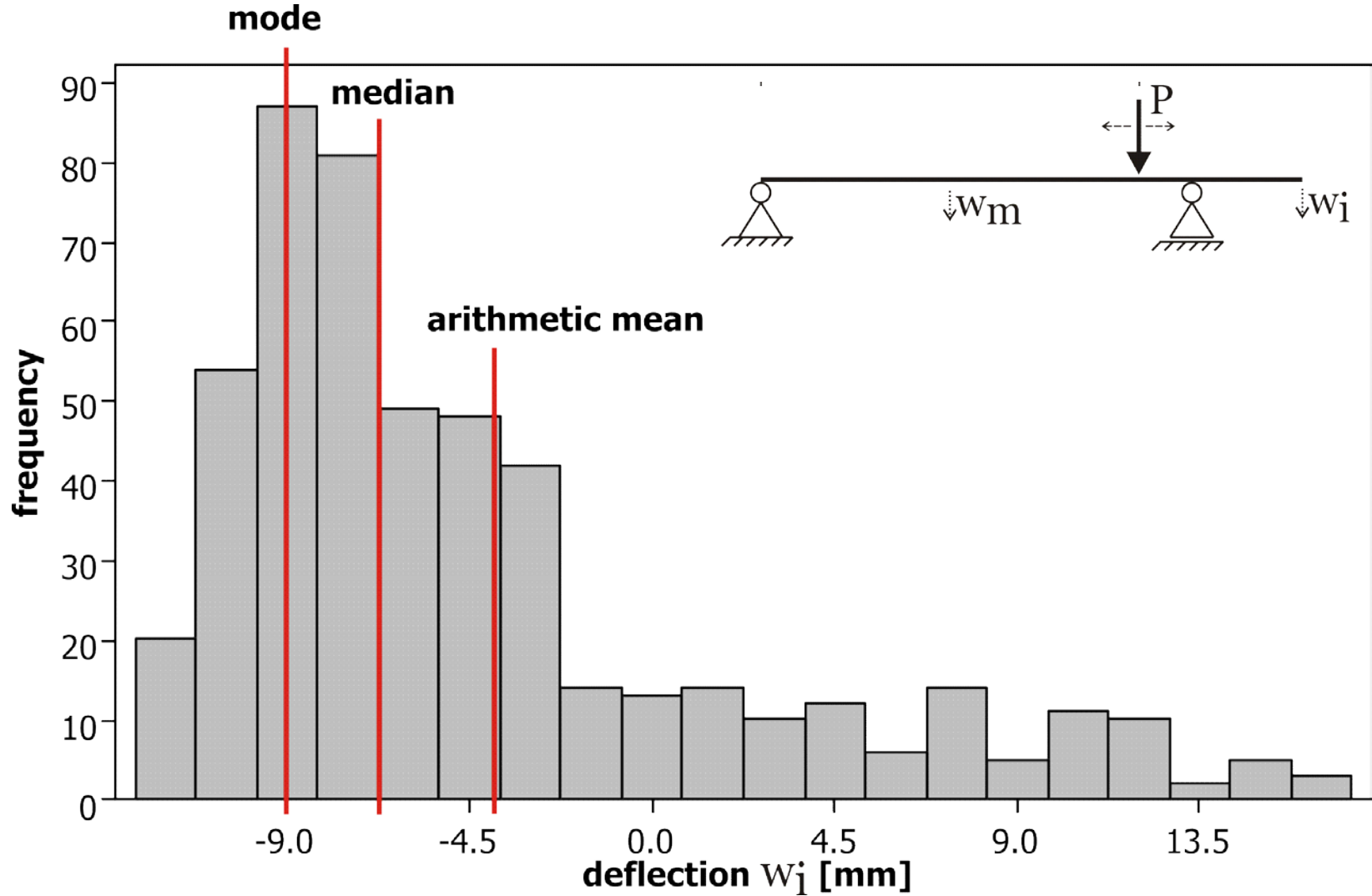
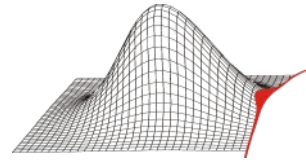
- centroid of the area underneath the density function
- sensitive towards outliers

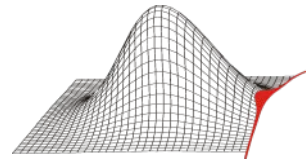
- **median:**

- divides the area below the probability density function into two pieces of equal size
- robust towards outliers

- **modal value or mode:**

- value of the data set, that occurs with the greatest frequency
- not necessarily unique.



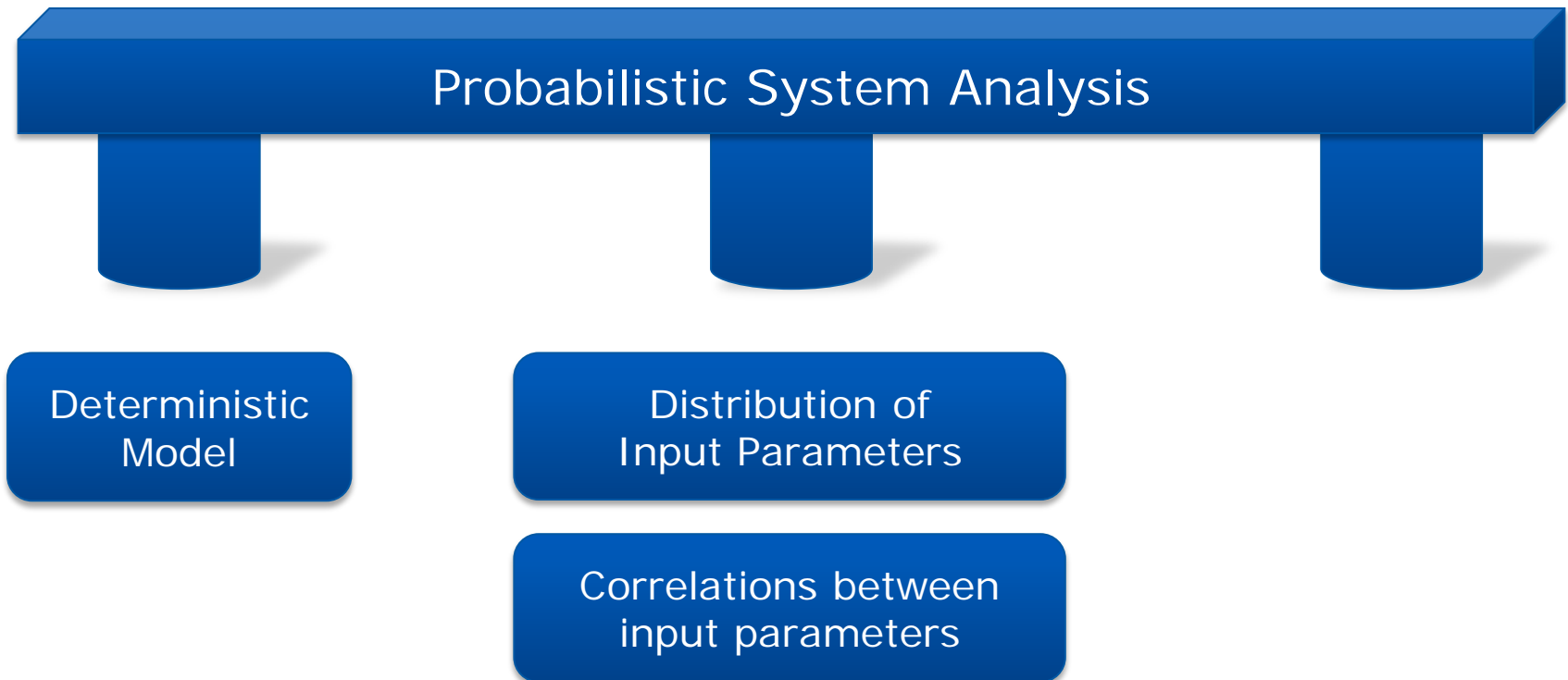
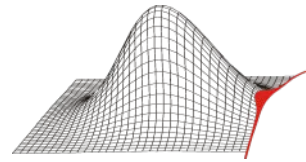


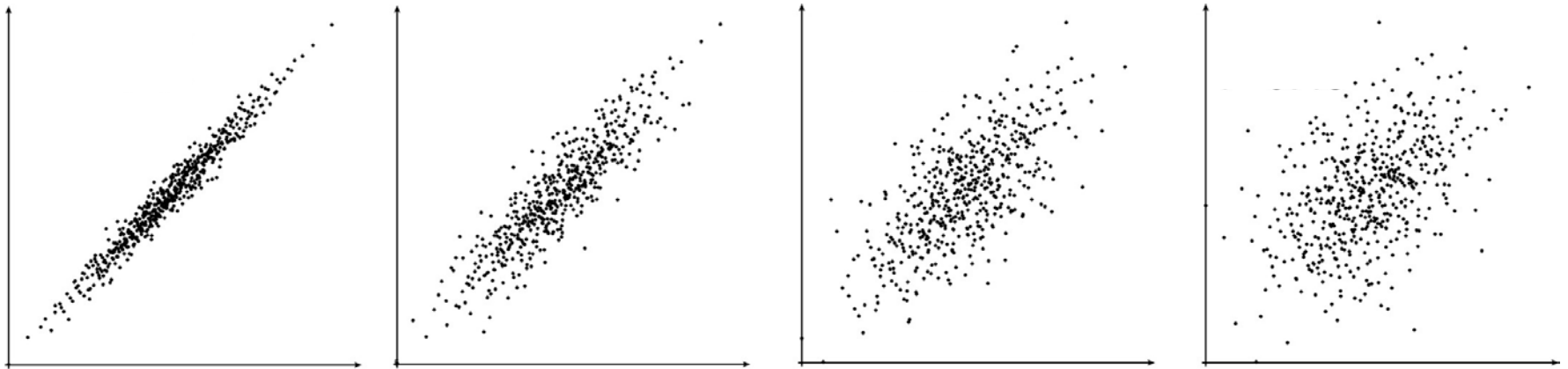
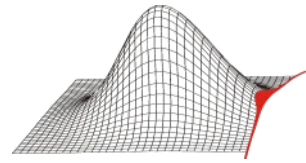
- **standard deviation:**

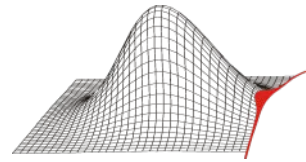
$$\sigma(b_{ri}) = \sqrt{\text{Var}(b_{ri})} = \sqrt{\frac{1}{n_{sim} - 1} \sum_{k=1}^{n_{sim}} (b_{ri,k} - \bar{b}_{ri})^2}$$

- **coefficient of variation:**

$$\delta(b_{ri}) = \frac{\sigma(b_{ri})}{\bar{b}_{ri}}$$







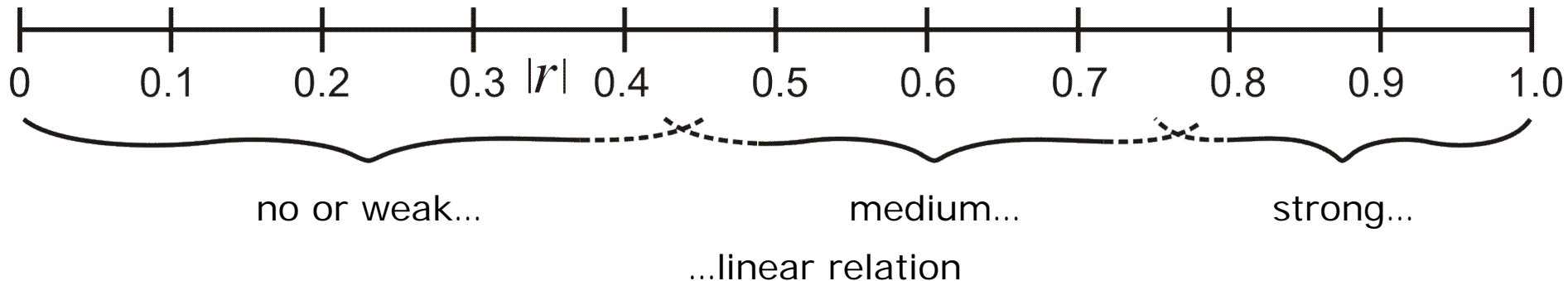
Pearson's Correlation Coefficient:

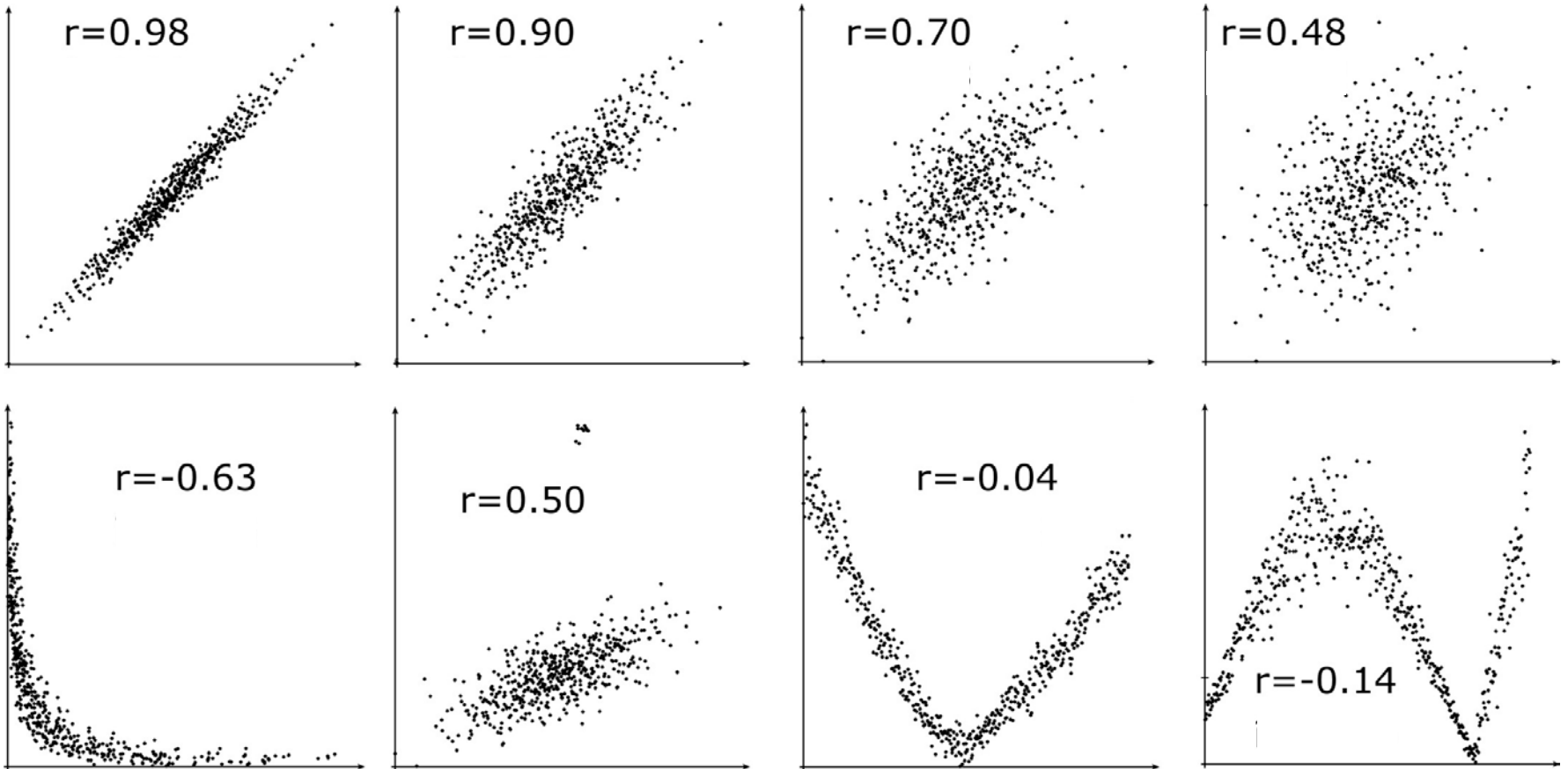
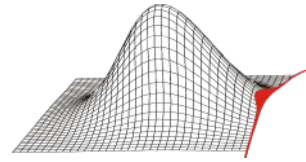
[1]

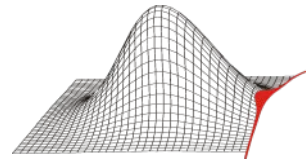
$$r_{b_{ri}b_{rj}} = \frac{\text{Cov}(b_{ri}, b_{rj})}{\sqrt{\text{Var}(b_{ri})}\sqrt{\text{Var}(b_{rj})}}$$

$$\text{Cov}(b_{ri}, b_{rj}) = \frac{1}{n_{sim} - 1} \sum_{k=1}^{n_{sim}} (b_{ri,k} - \bar{b}_{ri})(b_{rj,k} - \bar{b}_{rj})$$

Range: [-1,1]







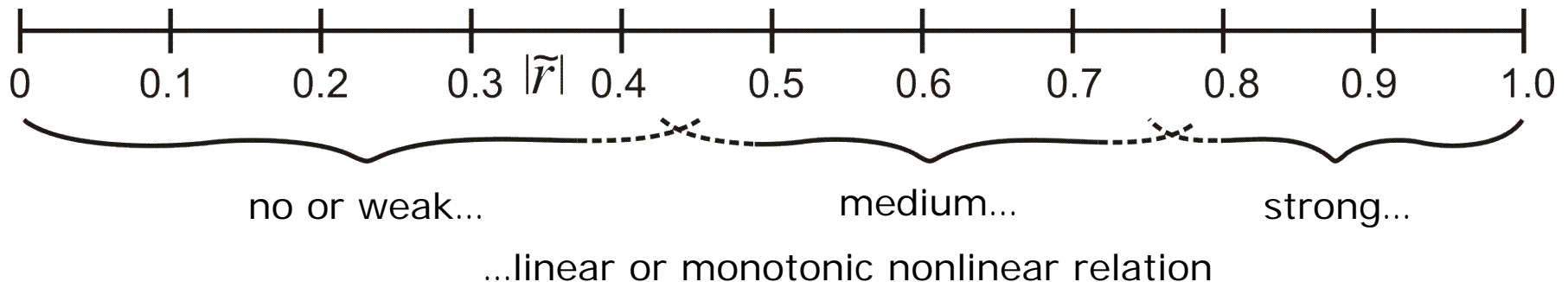
Spearman's Rank Correlation Coefficient

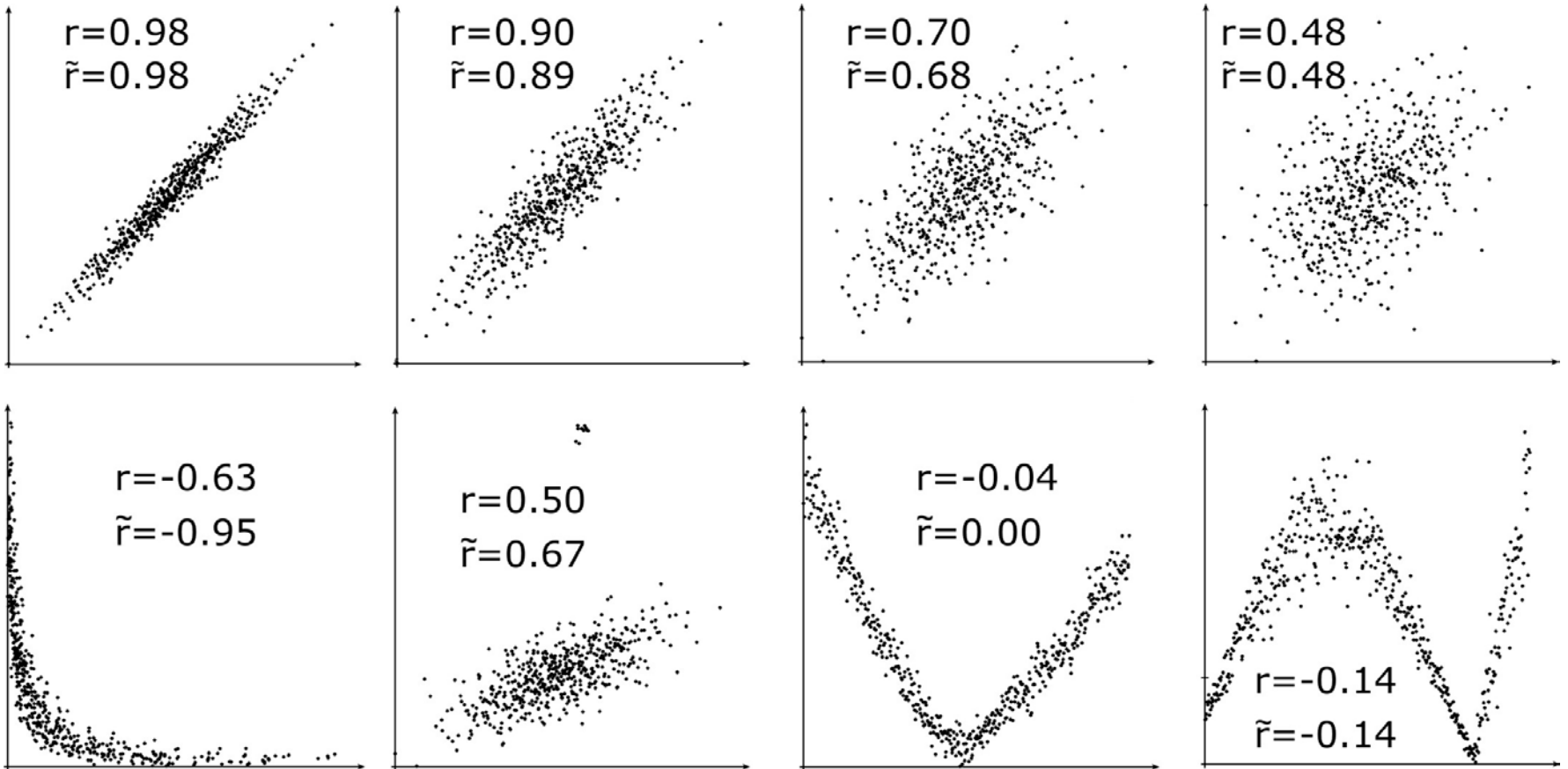
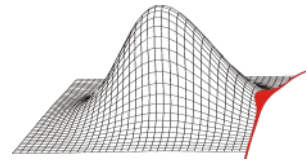
[1]

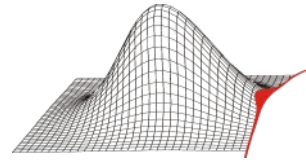
$$b_{ri} = \begin{bmatrix} b_{ri,1} \\ \vdots \\ b_{ri,n_{sim}} \end{bmatrix} \Rightarrow \text{Rank}(b_{ri}) = \begin{bmatrix} R_{b_{ri,1}} = \text{Rank of } b_{ri,1} \text{ in } b_{ri} \\ \vdots \\ R_{b_{ri,n_{sim}}} = \text{Rank of } b_{ri,n_{sim}} \text{ in } b_{ri} \end{bmatrix}$$

$$\tilde{r}_{b_{ri}b_{rj}} = \frac{\sum_{k=1}^{n_{sim}} (R_{b_{ri,k}} - \bar{R}_{b_{ri}})(R_{b_{rj,k}} - \bar{R}_{b_{rj}})}{\sqrt{\sum_{k=1}^{n_{sim}} (R_{b_{ri,k}} - \bar{R}_{b_{ri}})^2} \sqrt{\sum_{k=1}^{n_{sim}} (R_{b_{rj,k}} - \bar{R}_{b_{rj}})^2}}$$

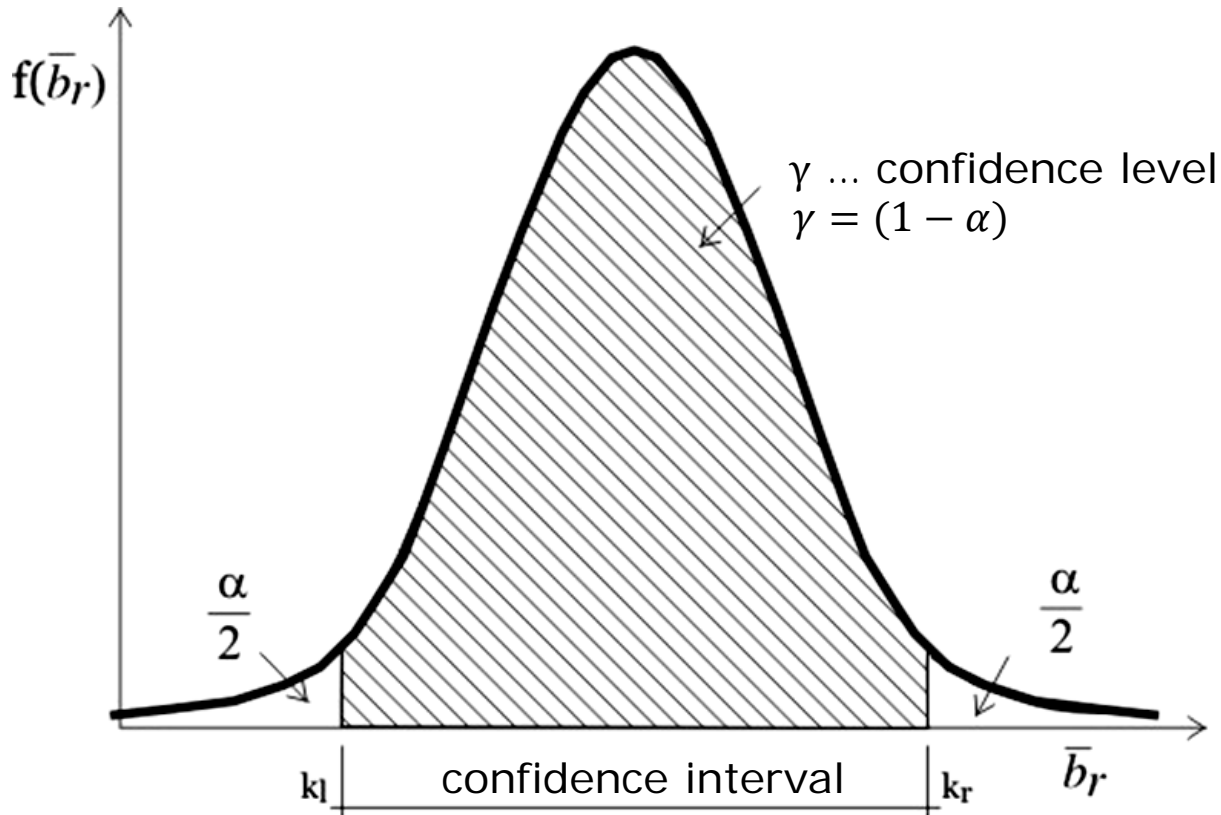
Range: [-1, 1]

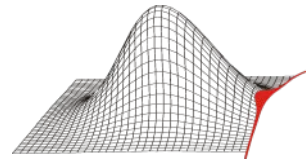






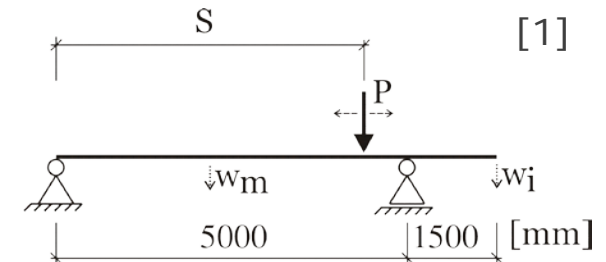
- Statistical measures (like mean, standard deviation, ...) are point estimations without any information about the quality of the estimation
- Confidence interval provides this information





- Relative frequency of an attribute/ event f :

(e.g. exceedance of a deflection limit)



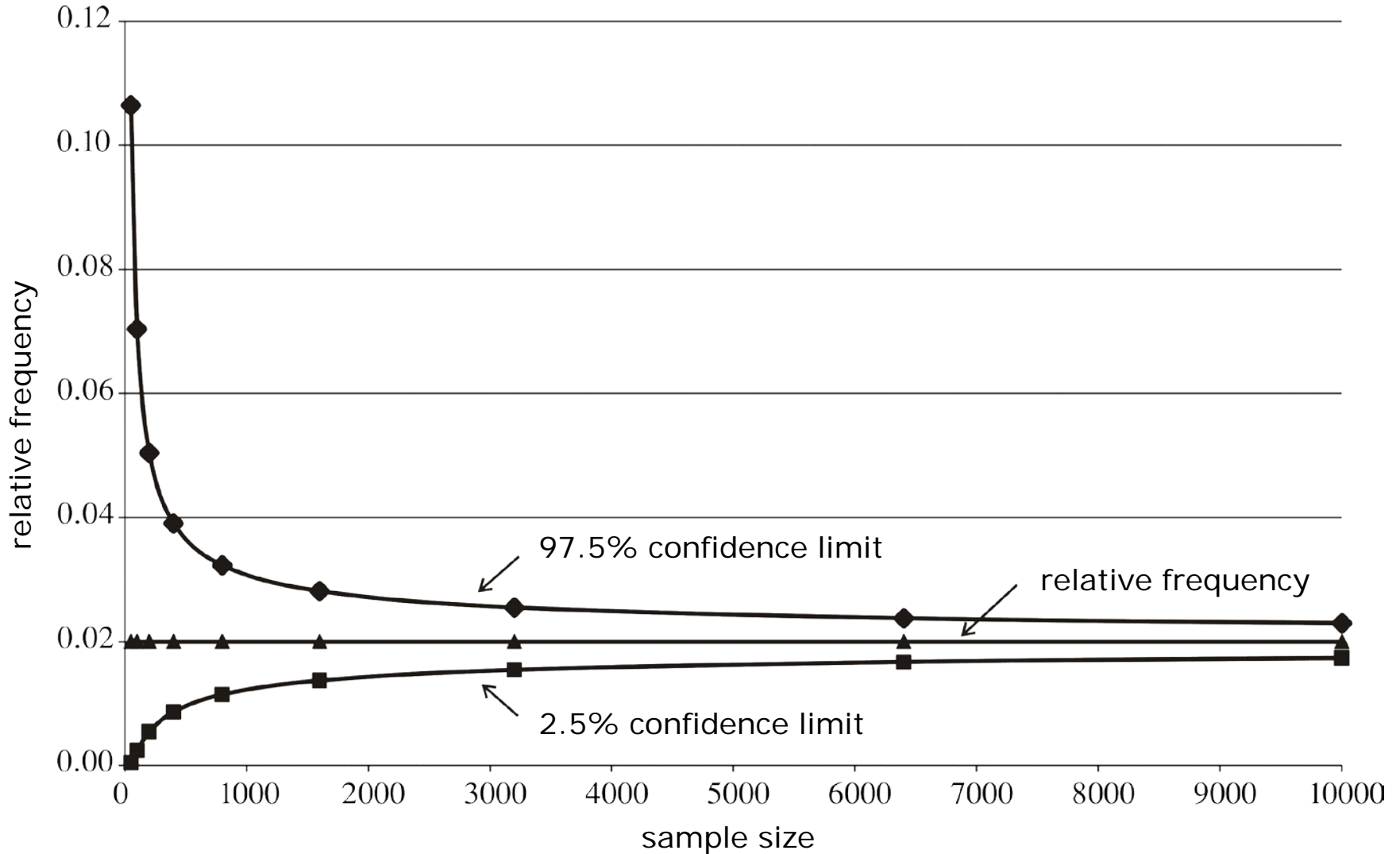
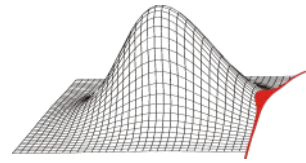
$$\hat{p} = \frac{n_f}{n_{sim}}; \quad \hat{p} \rightarrow p_{true} \quad \text{if} \quad n_{sim} \rightarrow \infty$$

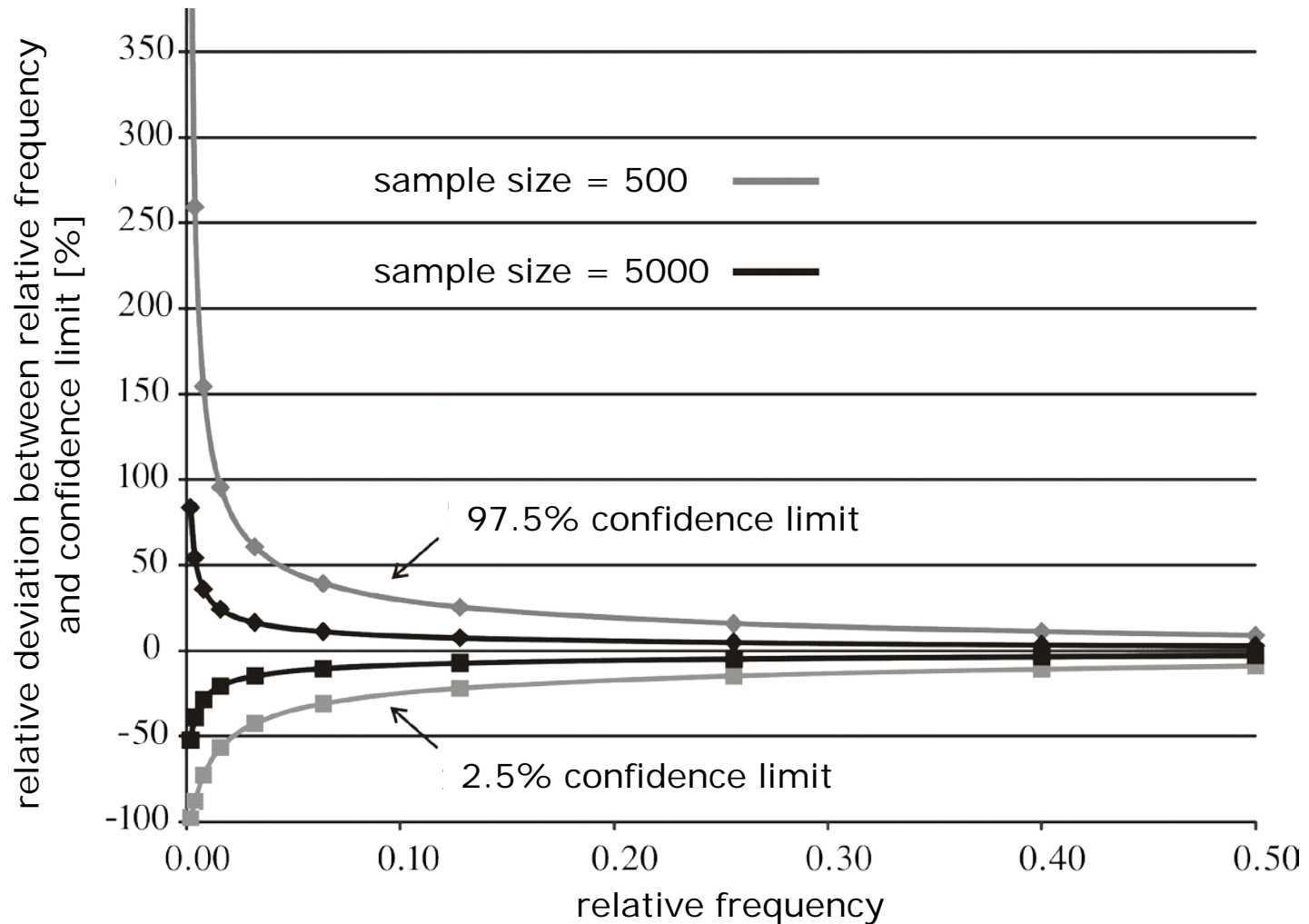
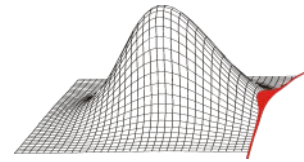
left confidence limit:

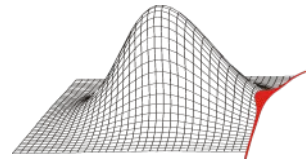
$$k_l = \frac{n_f}{n_f + (n_{sim} - n_f + 1) F_{\frac{\alpha}{2}; 2(n_{sim} - n_f + 1); 2n_f}}$$

right confidence limit:

$$k_r = \frac{(n_f + 1) F_{\frac{\alpha}{2}; 2(n_f + 1); 2(n_{sim} - n_f)}}{n_{sim} - n_f + (n_f + 1) F_{\frac{\alpha}{2}; 2(n_f + 1); 2(n_{sim} - n_f)}}$$







- The distribution of a correlation coefficient differs from the normal distribution, if its absolute value is significantly greater than zero [1]
- Ronald Aylmer Fisher : normalization via z-transformation in order to calculate the confidence limits [4]

$$\dot{z} = \operatorname{arctanh}(r)$$

left confidence limit:

$$k_l = \tanh(\dot{k}_l)$$

$$\dot{k}_l = \dot{z} - \frac{z_{1-\alpha/2}}{\sqrt{n_{sim} - 3}}$$

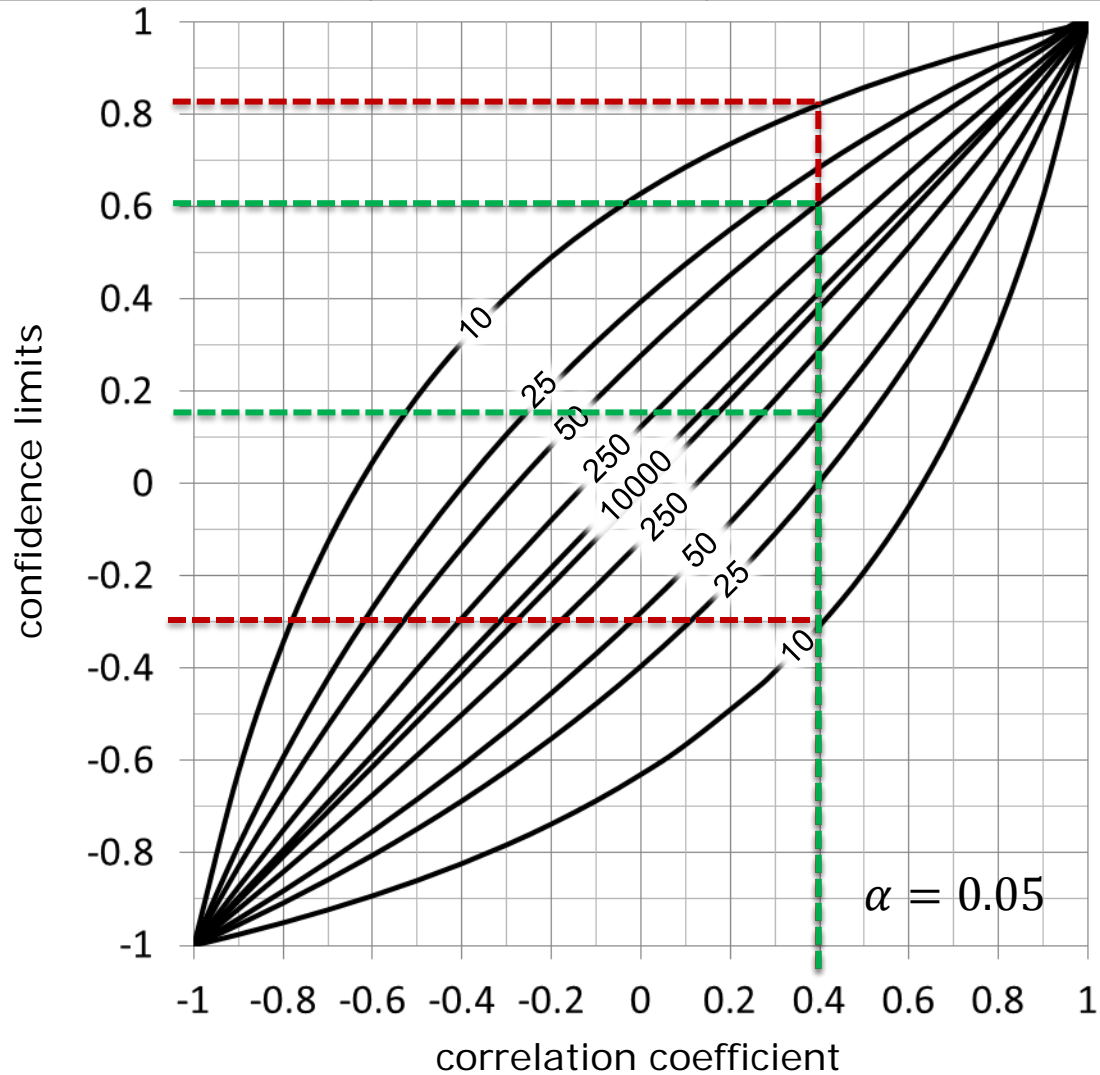
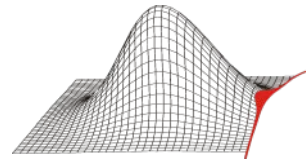
right confidence limit:

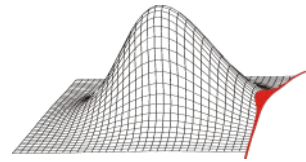
$$k_r = \tanh(\dot{k}_r)$$

$$\dot{k}_r = \dot{z} + \frac{z_{1-\alpha/2}}{\sqrt{n_{sim} - 3}}$$

[1] Sachs, L., 2004, Angewandte Statistik, Anwendung statistischer Methoden, Springer, Berlin/ Heidelberg/ New York

[4] Fisher, R. A., 1970, Statistical Methods for Research Workers, Oliver & Boyd, Edinburgh





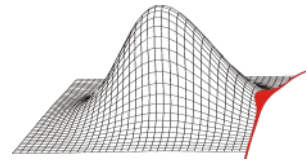
probabilistic system analysis

Deterministic
model

Distribution of
input parameters

Probabilistic
methods

Correlations between
input parameters



- [1] Sachs, L., 2004, *Angewandte Statistik, Anwendung statistischer Methoden*, Springer, Berlin / Heidelberg/ New York
- [2] Anderson, T. W., Darling, D.A., 1952, *Asymptotic Theory of Certain "Goodness of Fit" Criteria Based on Stochastic Processes*, Annals of Mathematical Statistics 23, Pages 193-212
- [3] Stephens, M.A., 1974, *EDF Statistics for Goodness of Fit and some Comparisons*, Journal of the American Statistical Association, Vol. 69, Pages 730-737
- [4] Fisher, R. A., 1970, *Statistical Methods for Research Workers*, Oliver & Boyd, Edinburgh